

## MOSFET

### 650V CoolMOS™ CFD7A SJ Power Device

650V CoolMOS™ CFD7A is Infineon's latest generation of market leading automotive qualified high voltage CoolMOS™ MOSFETs. In addition to the well-known attributes of high quality and reliability required by the automotive industry, the new CoolMOS™ CFD7A series provides for an integrated fast body diode and can be used for PFC and resonant switching topologies like the ZVS phase-shift full-bridge and LLC.

#### Features

- Latest 650V automotive qualified technology with integrated fast body diode on the market featuring ultra low  $Q_{rr}$
- Lowest FOM  $R_{DS(on)} \cdot Q_g$  and  $R_{DS(on)} \cdot E_{oss}$
- 100% avalanche tested
- Best-in-class  $R_{DS(on)}$  in SMD and THD packages

#### Benefits

- Optimized for higher battery voltages up to 475 V thanks to further improved robustness
- Lower switching losses enabling higher switching frequencies
- High quality and reliability
- Increased efficiency in light load and full load conditions

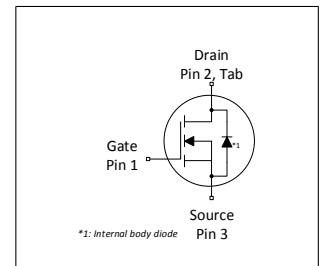
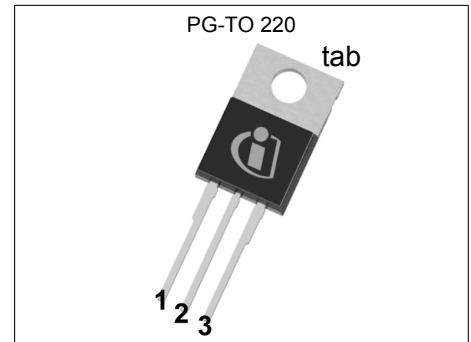
#### Potential applications

- Suitable for PFC and DC-DC stages for:
- Unidirectional and bidirectional DC-DC converters,
  - On-Board battery Chargers

#### Product validation

Qualified according to AEC Q101

*Please note: For production part approval process (PPAP) release we propose to share application related information during an early design phase to avoid delays in PPAP release. Please contact Infineon sales office.*



**Table 1 Key Performance Parameters**

| Parameter            | Value | Unit |
|----------------------|-------|------|
| $V_{DS}$             | 650   | V    |
| $R_{DS(on),max}$     | 99    | mΩ   |
| $Q_{g,typ}$          | 53    | nC   |
| $I_{D,pulse}$        | 107   | A    |
| $E_{oss} @ 400V$     | 6.8   | μJ   |
| Body diode $di_F/dt$ | 1300  | A/μs |

| Type / Ordering Code | Package    | Marking  | Related Links  |
|----------------------|------------|----------|----------------|
| IPP65R099CFD7A       | PG-TO220-3 | 65A099F7 | see Appendix A |

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## 1 Maximum ratings

at  $T_j = 25^\circ\text{C}$ , unless otherwise specified

**Table 2 Maximum ratings**

| Parameter                              | Symbol         | Values |      |          | Unit             | Note / Test Condition                                                                           |
|----------------------------------------|----------------|--------|------|----------|------------------|-------------------------------------------------------------------------------------------------|
|                                        |                | Min.   | Typ. | Max.     |                  |                                                                                                 |
| Continuous drain current <sup>1)</sup> | $I_D$          | -      | -    | 24<br>15 | A                | $T_C=25^\circ\text{C}$<br>$T_C=100^\circ\text{C}$                                               |
| Pulsed drain current <sup>2)</sup>     | $I_{D,pulse}$  | -      | -    | 107      | A                | $T_C=25^\circ\text{C}$                                                                          |
| Avalanche energy, single pulse         | $E_{AS}$       | -      | -    | 125      | mJ               | $I_D=5.0\text{A}$ ; $V_{DD}=50\text{V}$ ; see table 10                                          |
| Avalanche current, single pulse        | $I_{AS}$       | -      | -    | 5.0      | A                | -                                                                                               |
| MOSFET dv/dt ruggedness                | dv/dt          | -      | -    | 120      | V/ns             | $V_{DS}=0\dots400\text{V}$                                                                      |
| Gate source voltage (static)           | $V_{GS}$       | -20    | -    | 20       | V                | static;                                                                                         |
| Gate source voltage (dynamic)          | $V_{GS,pulse}$ | -30    | -    | 30       | V                | $f_{repetition} \leq 100\text{kHz}$ , $t_{pulse} \leq 2\text{ns}$                               |
| Power dissipation                      | $P_{tot}$      | -      | -    | 127      | W                | $T_C=25^\circ\text{C}$                                                                          |
| Storage temperature                    | $T_{stg}$      | -55    | -    | 150      | $^\circ\text{C}$ | -                                                                                               |
| Operating junction temperature         | $T_j$          | -40    | -    | 150      | $^\circ\text{C}$ | -                                                                                               |
| Mounting torque                        | -              | -      | -    | 60       | Ncm              | M3 and M3.5 screws                                                                              |
| Continuous diode forward current       | $I_S$          | -      | -    | 24       | A                | $T_C=25^\circ\text{C}$                                                                          |
| Diode pulse current <sup>2)</sup>      | $I_{S,pulse}$  | -      | -    | 107      | A                | $T_C=25^\circ\text{C}$                                                                          |
| Reverse diode dv/dt <sup>3)</sup>      | dv/dt          | -      | -    | 70       | V/ns             | $V_{DS}=0\dots400\text{V}$ , $I_{SD} \leq 12.5\text{A}$ , $T_j=25^\circ\text{C}$<br>see table 8 |
| Maximum diode commutation speed        | di/dt          | -      | -    | 1300     | A/ $\mu\text{s}$ | $V_{DS}=0\dots400\text{V}$ , $I_{SD} \leq 12.5\text{A}$ , $T_j=25^\circ\text{C}$<br>see table 8 |

<sup>1)</sup> Limited by  $T_{j,max}$ .

<sup>2)</sup> Pulse width  $t_p$  limited by  $T_{j,max}$ .

<sup>3)</sup> Identical low side and high side switch with identical  $R_\theta$ .

## 2 Thermal characteristics

**Table 3 Thermal characteristics**

| Parameter                                                  | Symbol     | Values |      |      | Unit | Note / Test Condition               |
|------------------------------------------------------------|------------|--------|------|------|------|-------------------------------------|
|                                                            |            | Min.   | Typ. | Max. |      |                                     |
| Thermal resistance, junction - case                        | $R_{thJC}$ | -      | -    | 0.98 | °C/W | -                                   |
| Soldering temperature, wavesoldering only allowed at leads | $T_{sold}$ | -      | -    | 260  | °C   | 1.6mm (0.063 in.) from case for 10s |

### 3 Electrical characteristics

at  $T_j=25^\circ\text{C}$ , unless otherwise specified

**Table 4 Static characteristics**

| Parameter                                    | Symbol        | Values |                |            | Unit     | Note / Test Condition                                                                                         |
|----------------------------------------------|---------------|--------|----------------|------------|----------|---------------------------------------------------------------------------------------------------------------|
|                                              |               | Min.   | Typ.           | Max.       |          |                                                                                                               |
| Drain-source breakdown voltage <sup>1)</sup> | $V_{(BR)DSS}$ | 650    | -              | -          | V        | $V_{GS}=0V$ , $I_D=1mA$                                                                                       |
| Gate threshold voltage <sup>2)</sup>         | $V_{(GS)th}$  | 3.5    | 4              | 4.5        | V        | $V_{DS}=V_{GS}$ , $I_D=0.63mA$                                                                                |
| Zero gate voltage drain current              | $I_{DSS}$     | -      | -              | 1          | $\mu A$  | $V_{DS}=650V$ , $V_{GS}=0V$ , $T_j=25^\circ\text{C}$<br>$V_{DS}=650V$ , $V_{GS}=0V$ , $T_j=150^\circ\text{C}$ |
| Gate-source leakage current                  | $I_{GSS}$     | -      | -              | 0.1        | $\mu A$  | $V_{GS}=20V$ , $V_{DS}=0V$                                                                                    |
| Drain-source on-state resistance             | $R_{DS(on)}$  | -      | 0.082<br>0.183 | 0.099<br>- | $\Omega$ | $V_{GS}=10V$ , $I_D=12.5A$ , $T_j=25^\circ\text{C}$<br>$V_{GS}=10V$ , $I_D=12.5A$ , $T_j=150^\circ\text{C}$   |
| Gate resistance                              | $R_G$         | -      | 5.9            | -          | $\Omega$ | $f=250kHz$ , open drain                                                                                       |

**Table 5 Dynamic characteristics**

External parasitic elements (PCB layout) influence switching behavior significantly.

Stray inductances and coupling capacitances must be minimized.

For layout recommendations please use provided application notes or contact Infineon sales office.

| Parameter                                                  | Symbol       | Values |      |      | Unit | Note / Test Condition                                                         |
|------------------------------------------------------------|--------------|--------|------|------|------|-------------------------------------------------------------------------------|
|                                                            |              | Min.   | Typ. | Max. |      |                                                                               |
| Input capacitance                                          | $C_{iss}$    | -      | 2513 | -    | pF   | $V_{GS}=0V$ , $V_{DS}=400V$ , $f=250kHz$                                      |
| Output capacitance                                         | $C_{oss}$    | -      | 36   | -    | pF   | $V_{GS}=0V$ , $V_{DS}=400V$ , $f=250kHz$                                      |
| Effective output capacitance, energy related <sup>3)</sup> | $C_{o(er)}$  | -      | 85   | -    | pF   | $V_{GS}=0V$ , $V_{DS}=0...400V$                                               |
| Effective output capacitance, time related <sup>4)</sup>   | $C_{o(tr)}$  | -      | 894  | -    | pF   | $I_D=\text{constant}$ , $V_{GS}=0V$ , $V_{DS}=0...400V$                       |
| Turn-on delay time                                         | $t_{d(on)}$  | -      | 25   | -    | ns   | $V_{DD}=400V$ , $V_{GS}=13V$ , $I_D=12.5A$ ,<br>$R_G=5.3\Omega$ ; see table 9 |
| Rise time                                                  | $t_r$        | -      | 11   | -    | ns   | $V_{DD}=400V$ , $V_{GS}=13V$ , $I_D=12.5A$ ,<br>$R_G=5.3\Omega$ ; see table 9 |
| Turn-off delay time                                        | $t_{d(off)}$ | -      | 92   | -    | ns   | $V_{DD}=400V$ , $V_{GS}=13V$ , $I_D=12.5A$ ,<br>$R_G=5.3\Omega$ ; see table 9 |
| Fall time                                                  | $t_f$        | -      | 5    | -    | ns   | $V_{DD}=400V$ , $V_{GS}=13V$ , $I_D=12.5A$ ,<br>$R_G=5.3\Omega$ ; see table 9 |

<sup>1)</sup> For applications with applied blocking voltage > 475 V, we recommend to evaluate the impact of the cosmic radiation effect in early design phase. For assessment, please contact local Infineon sales office.

<sup>2)</sup> We do not recommend using the CoolMOS mentioned in this datasheet to operate in "linear mode". For assessment of potential "linear mode", please contact Infineon sales office.

<sup>3)</sup>  $C_{o(er)}$  is a fixed capacitance that gives the same stored energy as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 400V

<sup>4)</sup>  $C_{o(tr)}$  is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 400V

**Table 6 Gate charge characteristics**

| Parameter             | Symbol        | Values |      |      | Unit | Note / Test Condition                             |
|-----------------------|---------------|--------|------|------|------|---------------------------------------------------|
|                       |               | Min.   | Typ. | Max. |      |                                                   |
| Gate to source charge | $Q_{gs}$      | -      | 15   | -    | nC   | $V_{DD}=400V$ , $I_D=12.5A$ , $V_{GS}=0$ to $10V$ |
| Gate to drain charge  | $Q_{gd}$      | -      | 16   | -    | nC   | $V_{DD}=400V$ , $I_D=12.5A$ , $V_{GS}=0$ to $10V$ |
| Gate charge total     | $Q_g$         | -      | 53   | -    | nC   | $V_{DD}=400V$ , $I_D=12.5A$ , $V_{GS}=0$ to $10V$ |
| Gate plateau voltage  | $V_{plateau}$ | -      | 5.7  | -    | V    | $V_{DD}=400V$ , $I_D=12.5A$ , $V_{GS}=0$ to $10V$ |

**Table 7 Reverse diode characteristics**

| Parameter                     | Symbol    | Values |      |      | Unit    | Note / Test Condition                                         |
|-------------------------------|-----------|--------|------|------|---------|---------------------------------------------------------------|
|                               |           | Min.   | Typ. | Max. |         |                                                               |
| Diode forward voltage         | $V_{SD}$  | -      | 1.1  | -    | V       | $V_{GS}=0V$ , $I_F=12.5A$ , $T_J=25^\circ C$                  |
| Reverse recovery time         | $t_{rr}$  | -      | 147  | -    | ns      | $V_R=400V$ , $I_F=12.5A$ , $di_F/dt=100A/\mu s$ ; see table 8 |
| Reverse recovery charge       | $Q_{rr}$  | -      | 0.78 | -    | $\mu C$ | $V_R=400V$ , $I_F=12.5A$ , $di_F/dt=100A/\mu s$ ; see table 8 |
| Peak reverse recovery current | $I_{rrm}$ | -      | 9.8  | -    | A       | $V_R=400V$ , $I_F=12.5A$ , $di_F/dt=100A/\mu s$ ; see table 8 |

## 4 Electrical characteristics diagrams

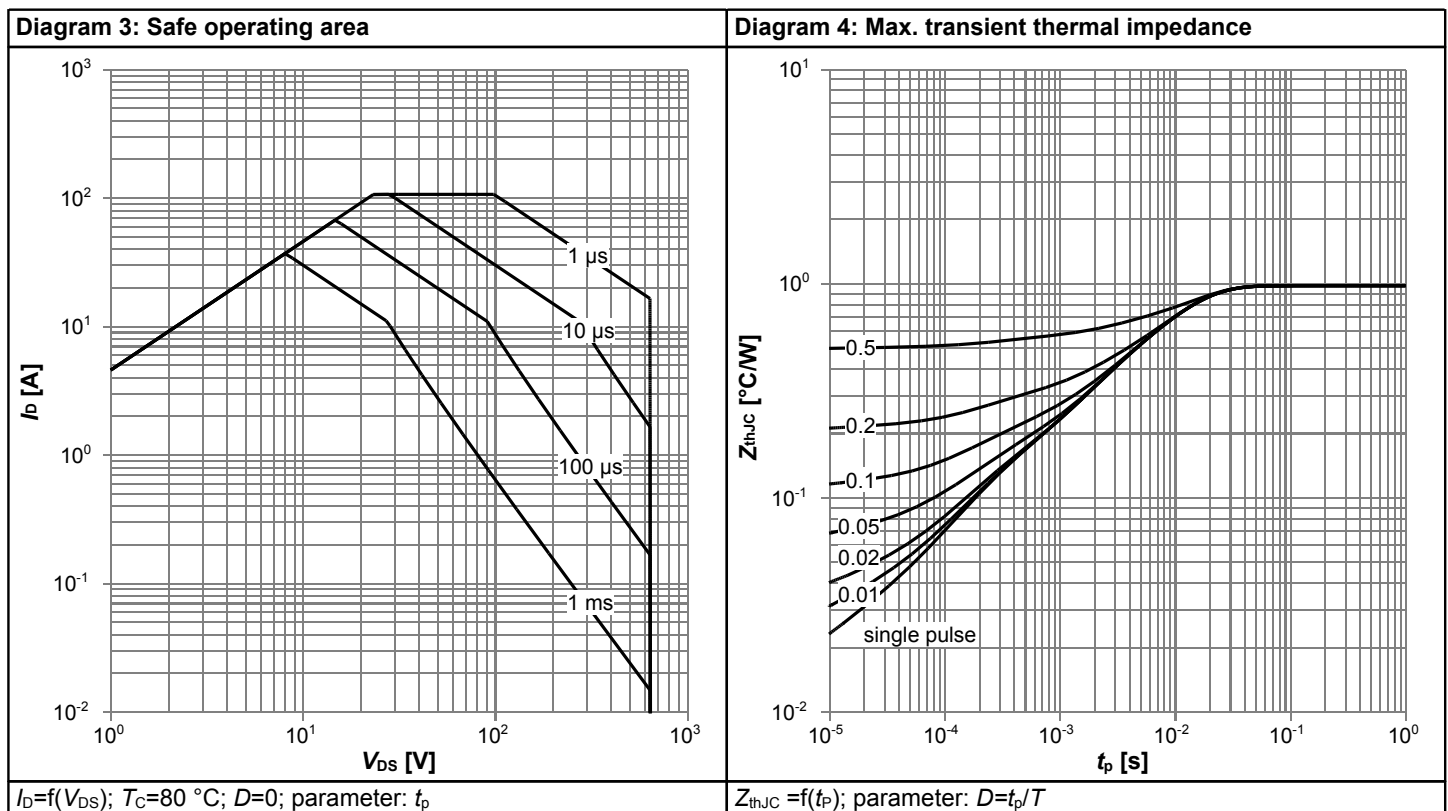
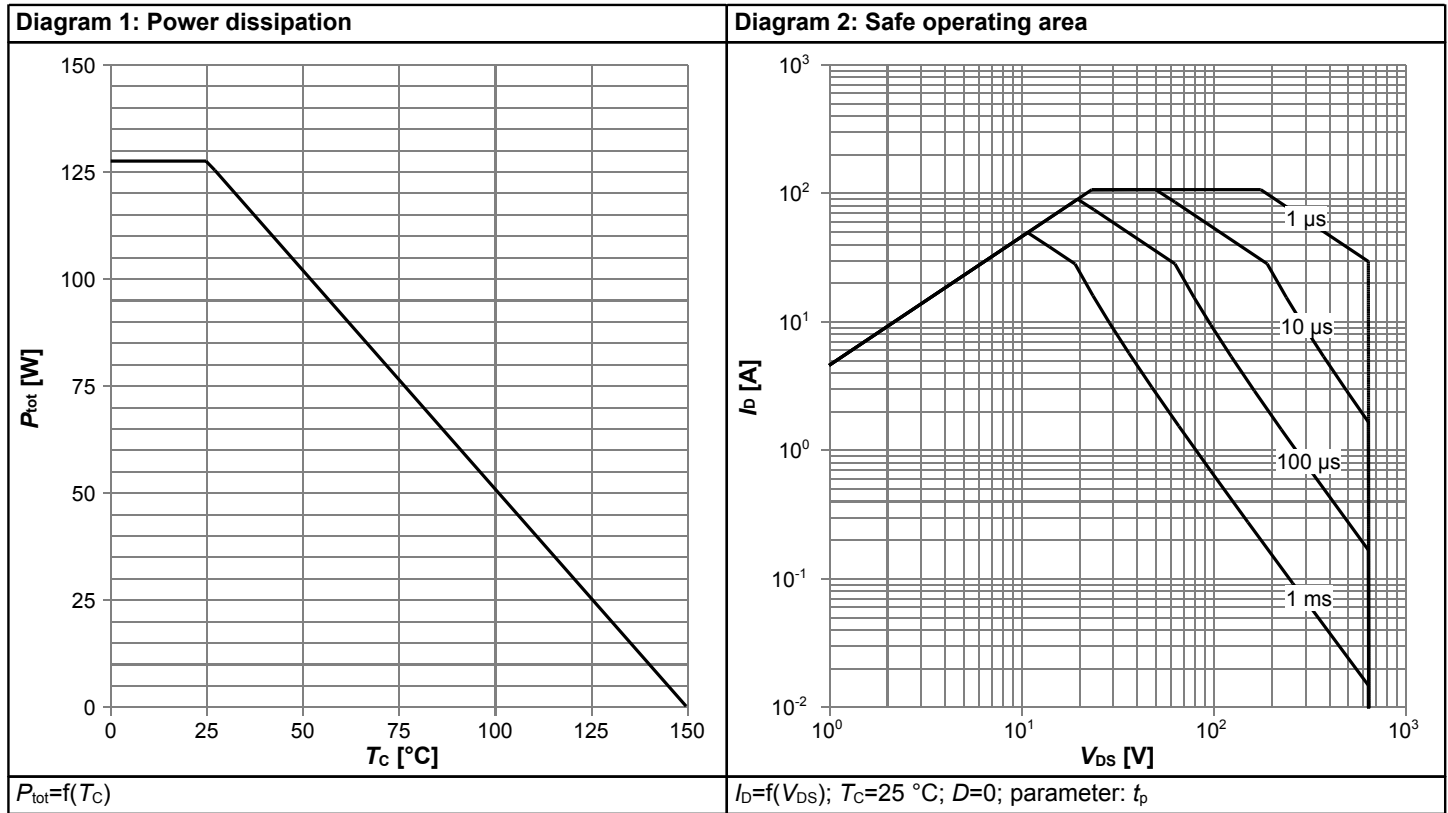
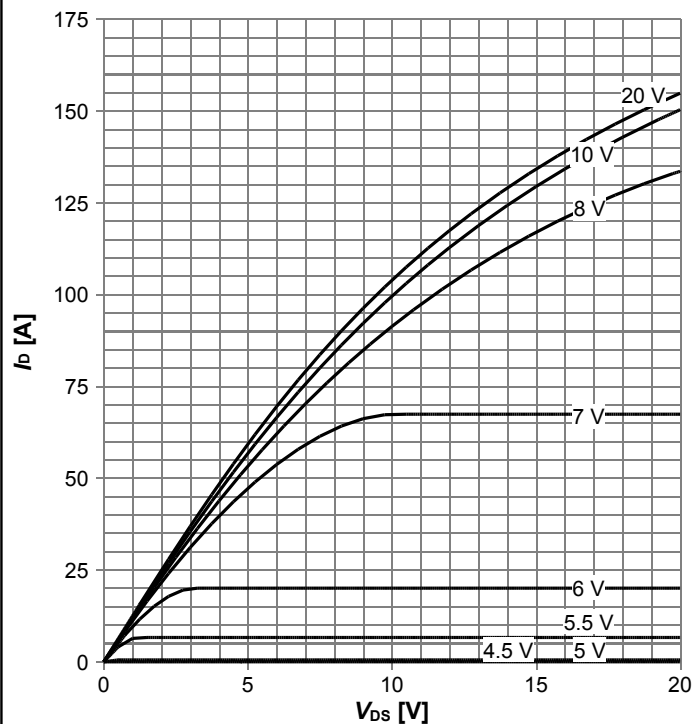
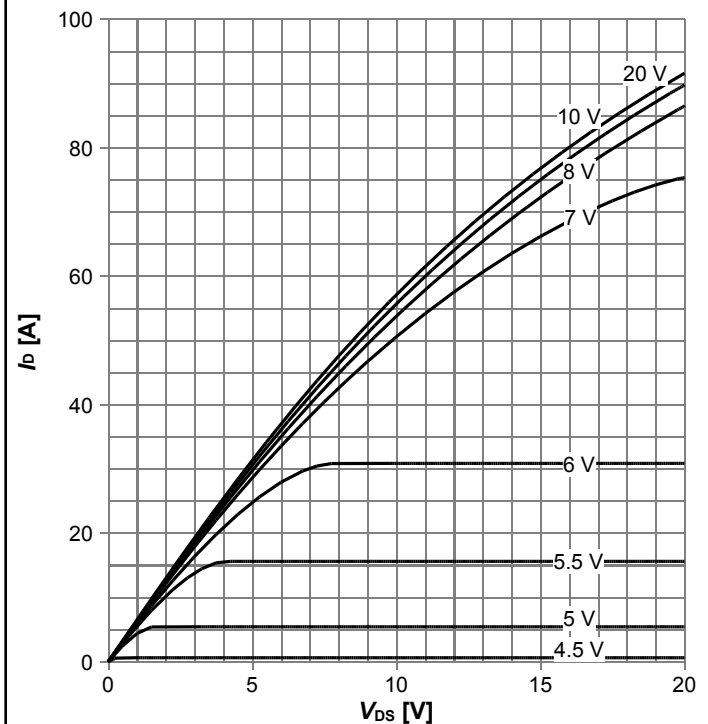


Diagram 5: Typ. output characteristics



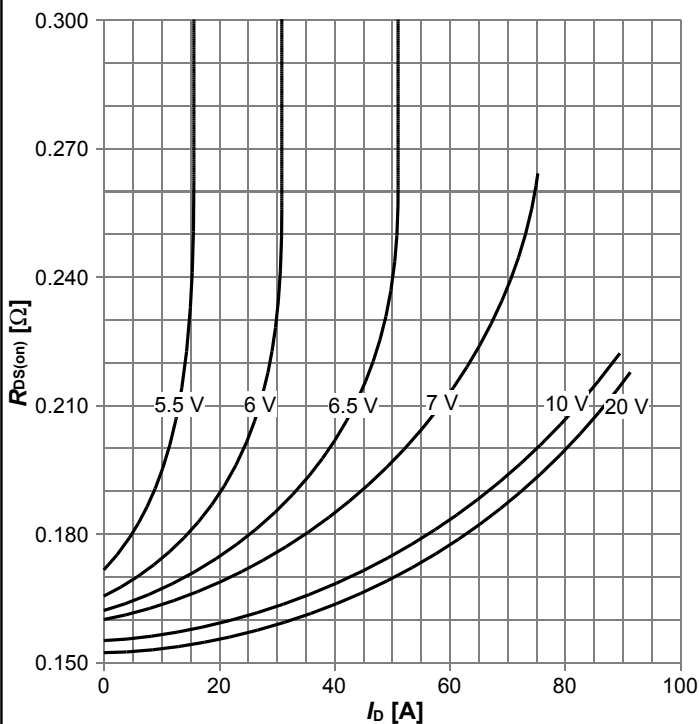
$I_D = f(V_{DS})$ ;  $T_J = 25\text{ °C}$ ; parameter:  $V_{GS}$

Diagram 6: Typ. output characteristics



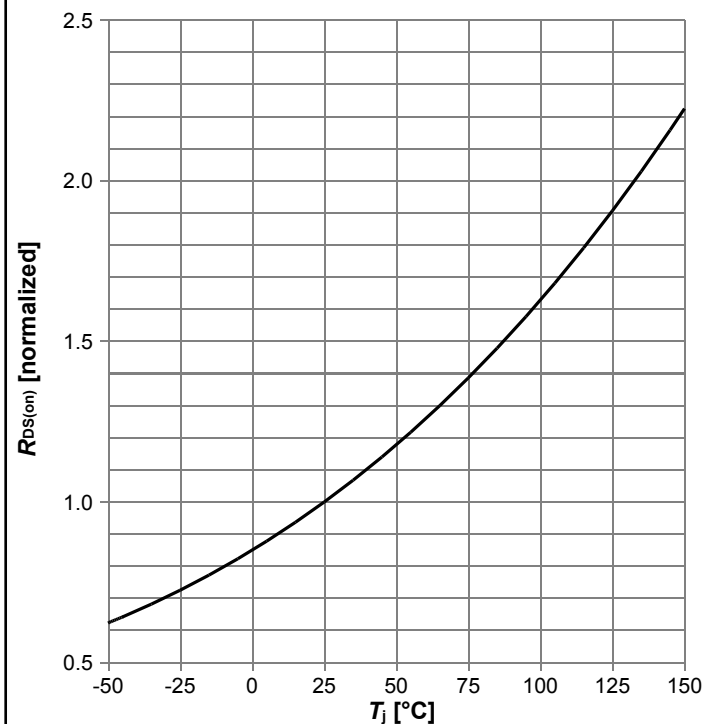
$I_D = f(V_{DS})$ ;  $T_J = 125\text{ °C}$ ; parameter:  $V_{GS}$

Diagram 7: Typ. drain-source on-state resistance



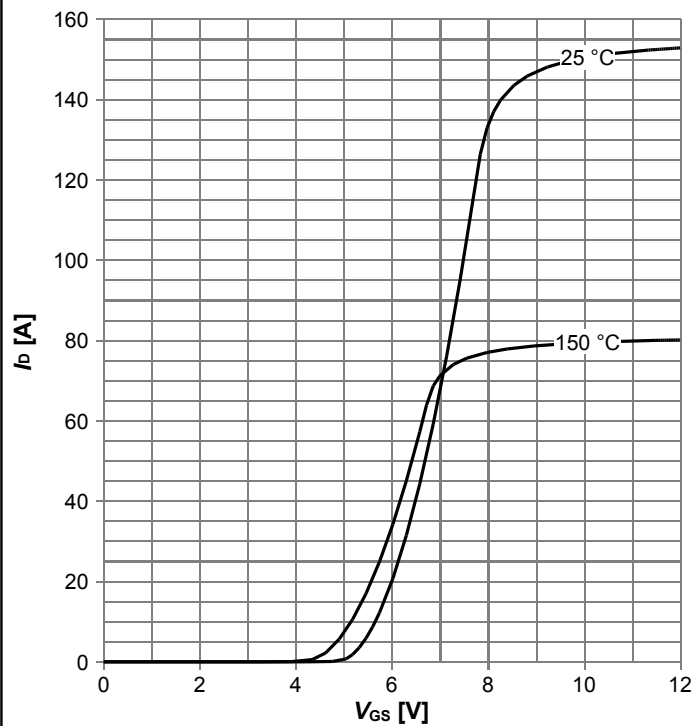
$R_{DS(on)} = f(I_D)$ ;  $T_J = 125\text{ °C}$ ; parameter:  $V_{GS}$

Diagram 8: Drain-source on-state resistance



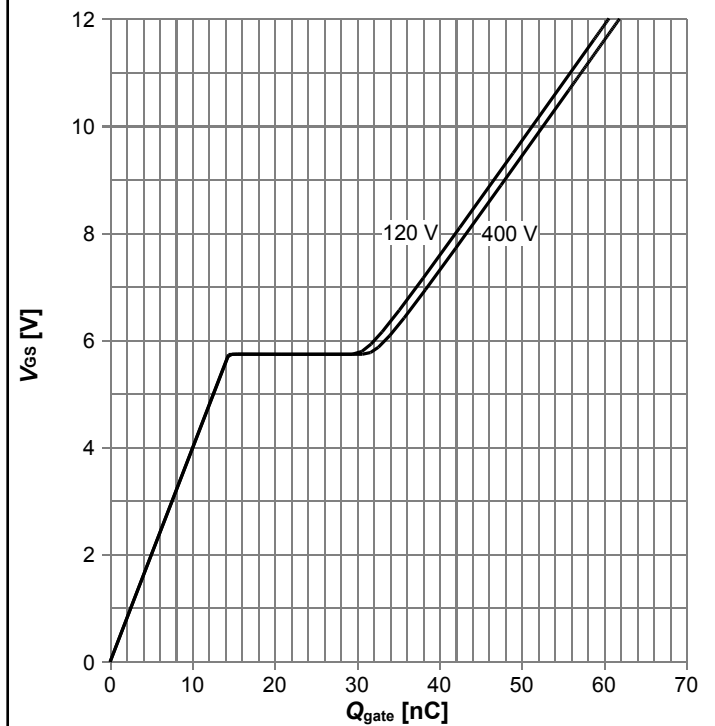
$R_{DS(on)} = f(T_J)$ ;  $I_D = 12.5\text{ A}$ ;  $V_{GS} = 10\text{ V}$

**Diagram 9: Typ. transfer characteristics**



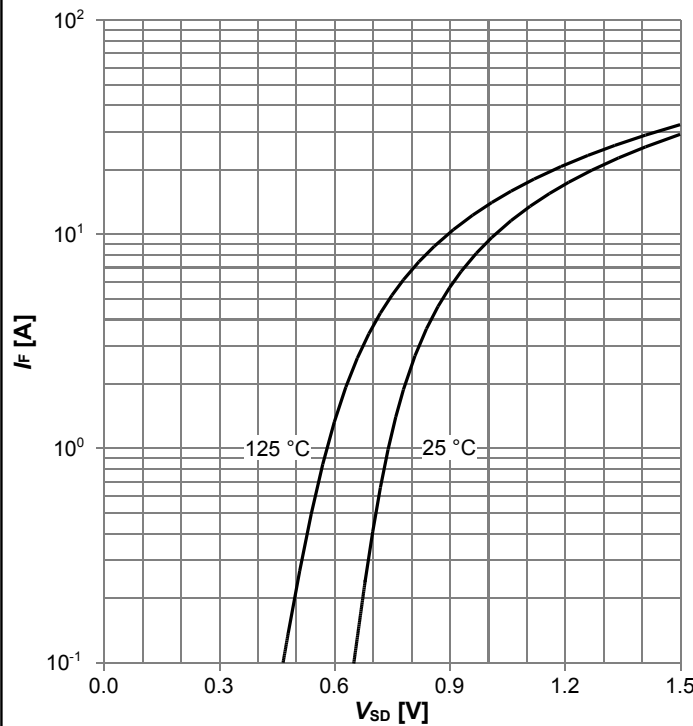
$I_D = f(V_{GS})$ ;  $V_{DS} = 20V$ ; parameter:  $T_j$

**Diagram 10: Typ. gate charge**



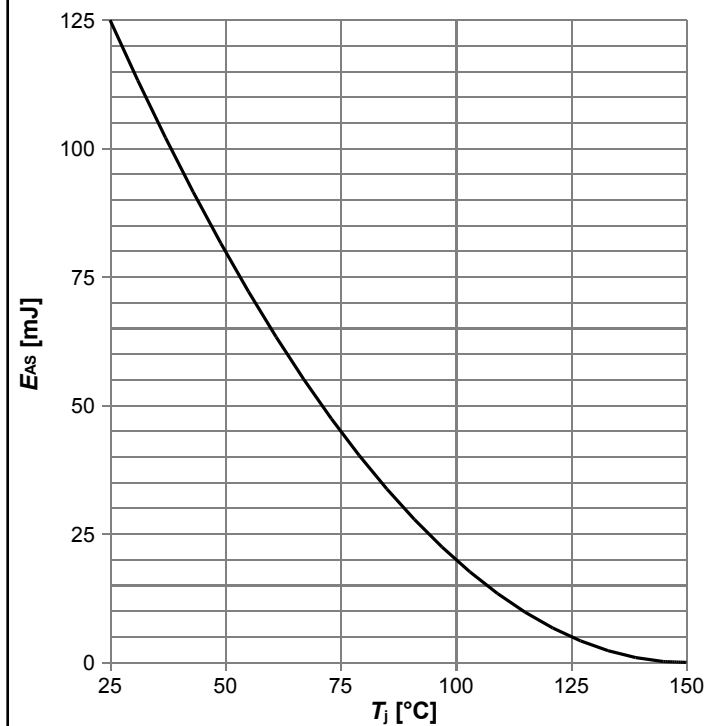
$V_{GS} = f(Q_{gate})$ ;  $I_D = 12.5$  A pulsed; parameter:  $V_{DD}$

**Diagram 11: Forward characteristics of reverse diode**



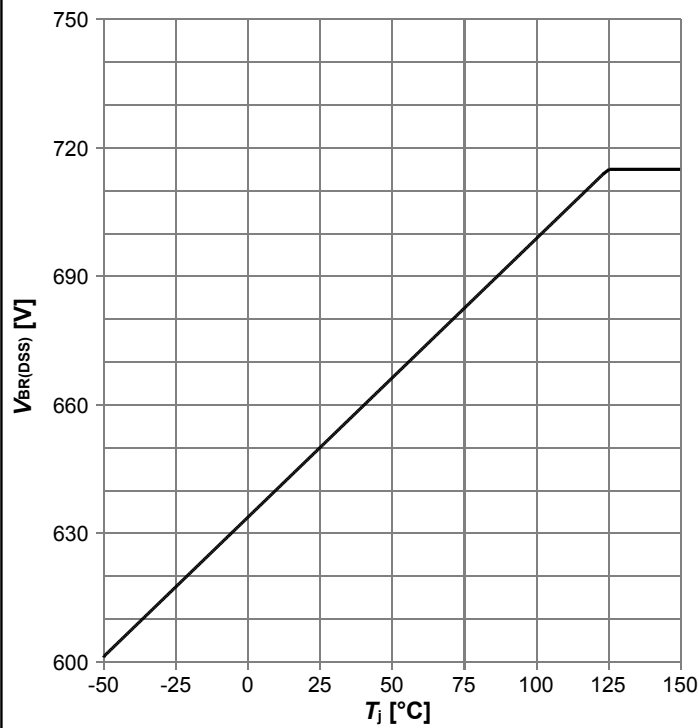
$I_F = f(V_{SD})$ ; parameter:  $T_j$

**Diagram 12: Avalanche energy**



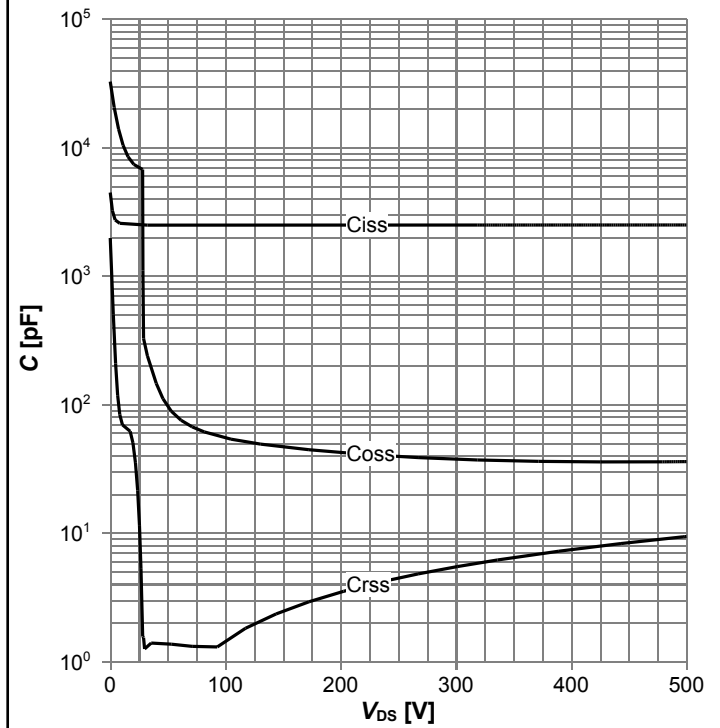
$E_{AS} = f(T_j)$ ;  $I_D = 5.0$  A;  $V_{DD} = 50$  V

**Diagram 13: Drain-source breakdown voltage**



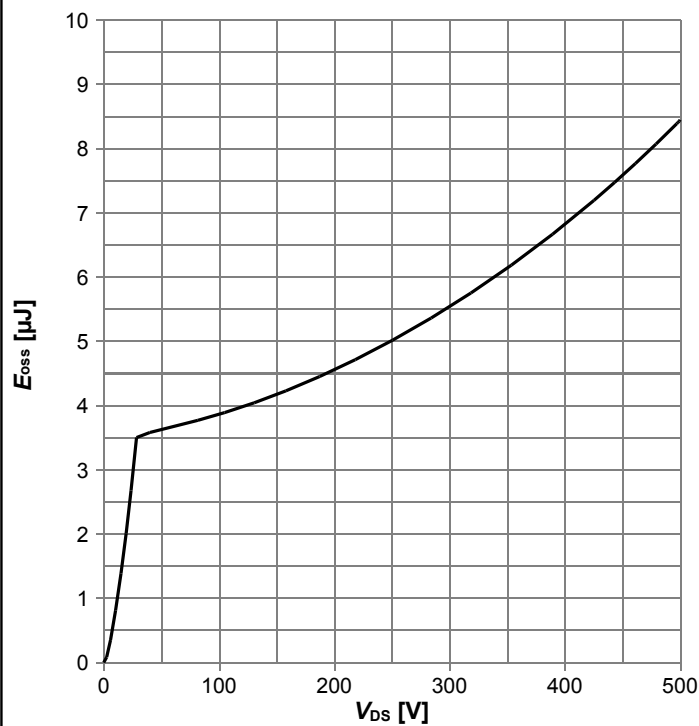
$V_{BR(DSS)} = f(T_J); I_D = 1 \text{ mA}$

**Diagram 14: Typ. capacitances**



$C = f(V_{DS}); V_{GS} = 0 \text{ V}; f = 250 \text{ kHz}$

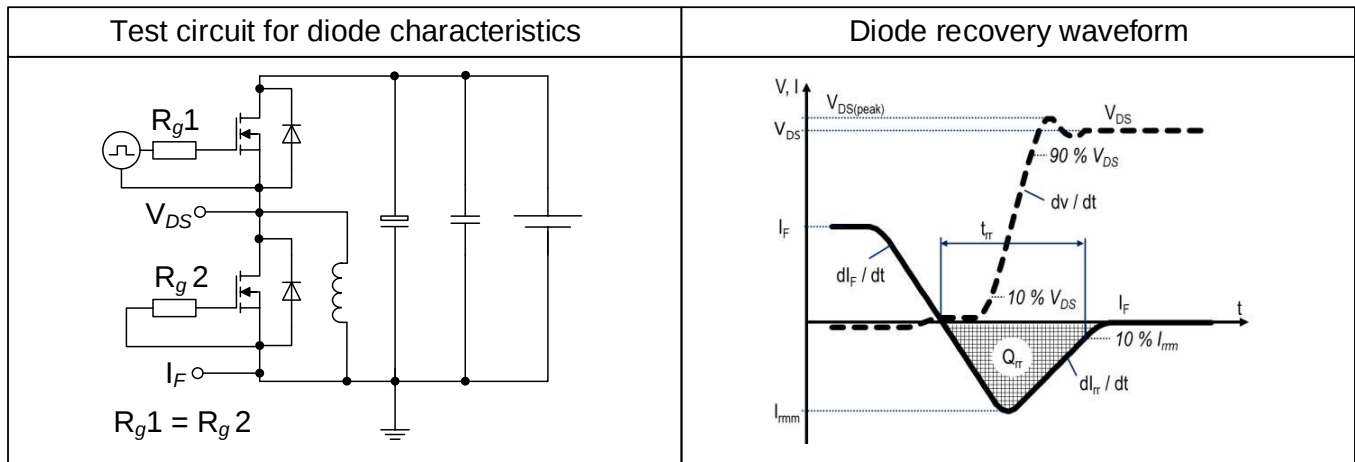
**Diagram 15: Typ. Coss stored energy**



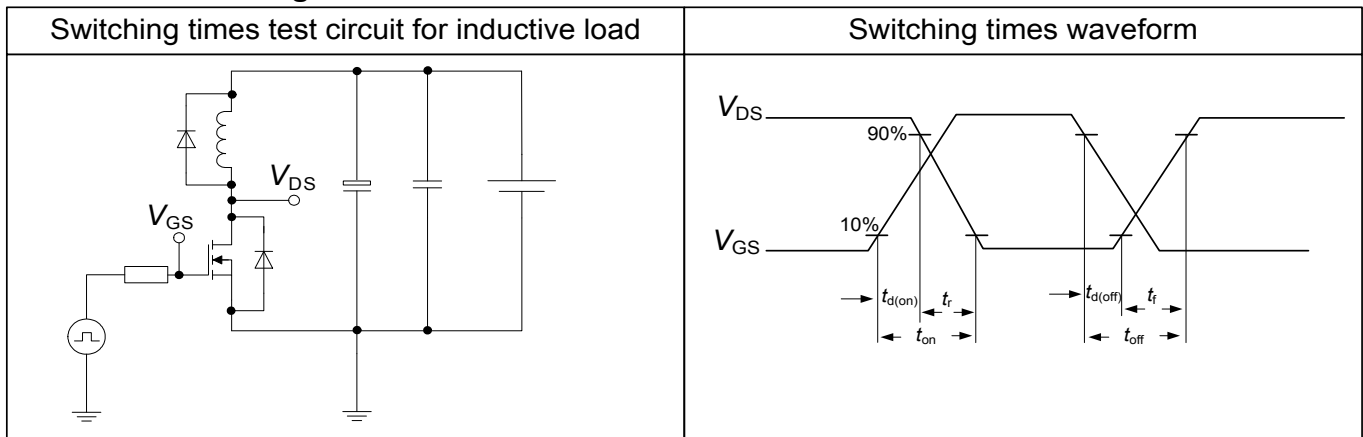
$E_{oss} = f(V_{DS})$

## 5 Test Circuits

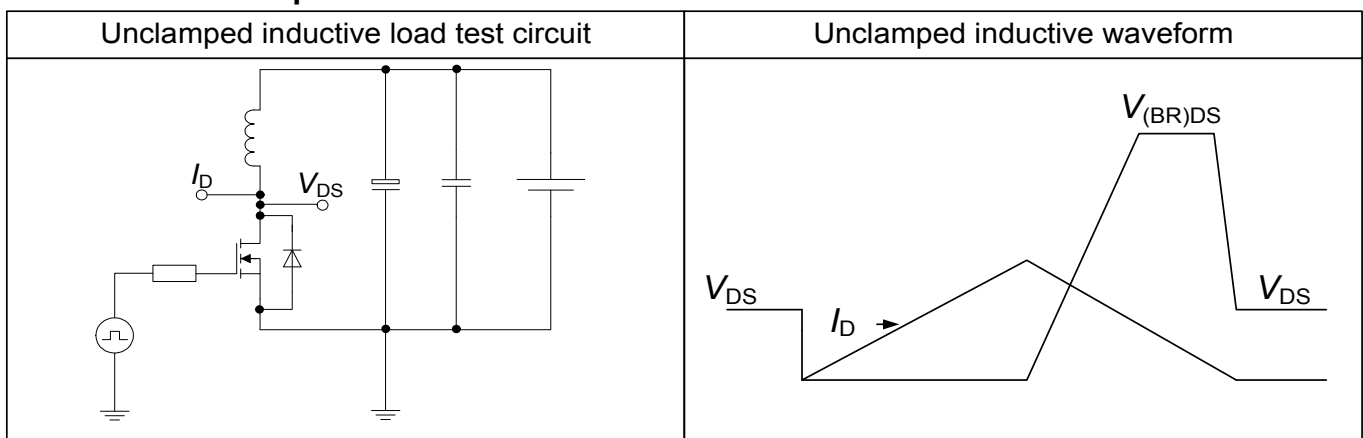
### Table 8 Diode characteristics



### Table 9 Switching times



### Table 10 Unclamped inductive load



## 6 Package Outlines

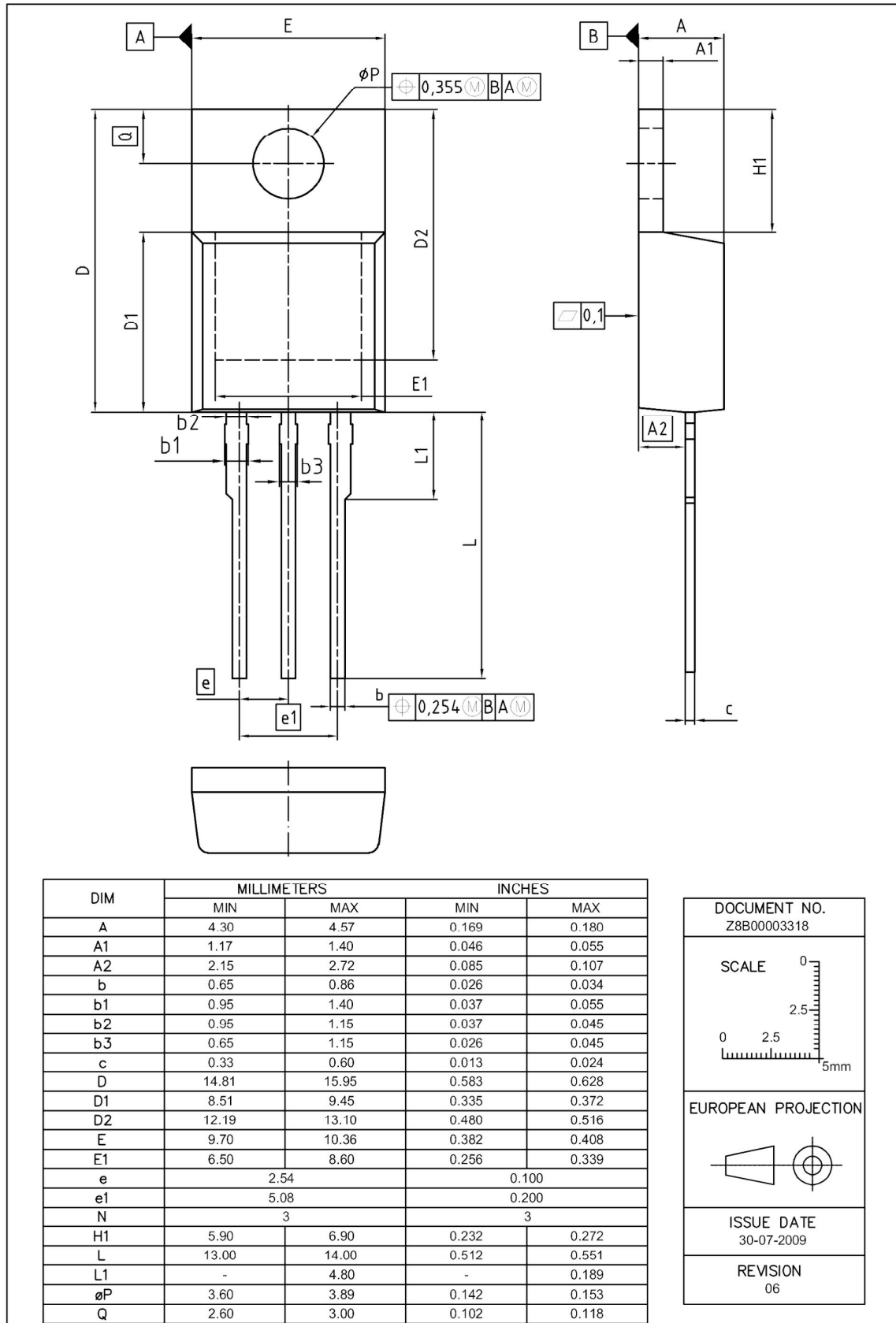


Figure 1 Outline PG-TO220-3, dimensions in mm/inches

## **7 Appendix A**

### **Table 11 Related Links**

- IFX CoolMOS CFD7A Webpage: [www.infineon.com](http://www.infineon.com)
- IFX CoolMOS CFD7A application note: [www.infineon.com](http://www.infineon.com)
- IFX CoolMOS CFD7A simulation model: [www.infineon.com](http://www.infineon.com)
- IFX Design tools: [www.infineon.com](http://www.infineon.com)

## Revision History

IPP65R099CFD7A

**Revision: 2020-03-25, Rev. 2.0**

Previous Revision

| Revision | Date       | Subjects (major changes since last revision)                 |
|----------|------------|--------------------------------------------------------------|
| 0.9      | 2017-10-13 | Release of target version                                    |
| 0.91     | 2017-11-29 | Update of Vds on page 1, switching times and test conditions |
| 0.92     | 2018-12-10 | Target                                                       |
| 2.0      | 2020-03-25 | Release of final version                                     |

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